

Philips Components

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10181

Arithmetic Unit

4-Bit Arithmetic Logic Unit/Function Generator

FEATURES

- Typical propagation delay: 4.2ns
- Typical supply current ($-I_{EE}$): 130mA

DESCRIPTION

The 10181 is a high-speed, Arithmetic Logic Unit. It performs 16 logic operations and 16 arithmetic operations on two 4-bit words. Arithmetic or logic mode of operation is selected by the mode control (M). Arithmetic logic operations are selected by a 4-bit select input ($S_0 - S_3$) in accordance with the function table. The device provides a group Carry Propagate (PG) and a Carry Generate (GG) for high-speed operations on very long words, using a 10179 as a high order look-ahead carry block. The internal carry is enabled while the mode control input (M) is Low (arithmetic operation).

All unused inputs can be left open due to integrated pull-down resistors which avoid the need for a supply voltage.

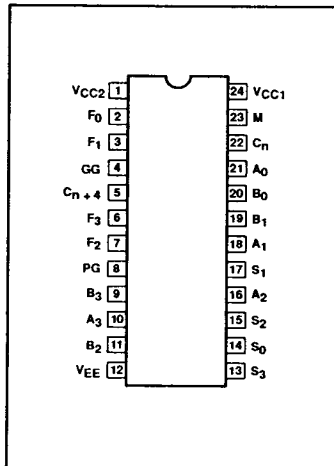
ORDERING INFORMATION

DESCRIPTION	ORDER CODE
24-Pin Plastic DIP	10181N
24-Pin Ceramic DIP	10181F

PIN DESCRIPTION

PINS	DESCRIPTION
M	Mode Control Input
$A_0 - A_3, B_0 - B_3$	Operand Inputs
$S_0 - S_3$	Function Select Inputs
C_n	Carry Inputs
$F_0 - F_3$	Data Outputs
C_{n+4}	Carry Output
GG	Carry Generate Output
PG	Carry Propagate Output

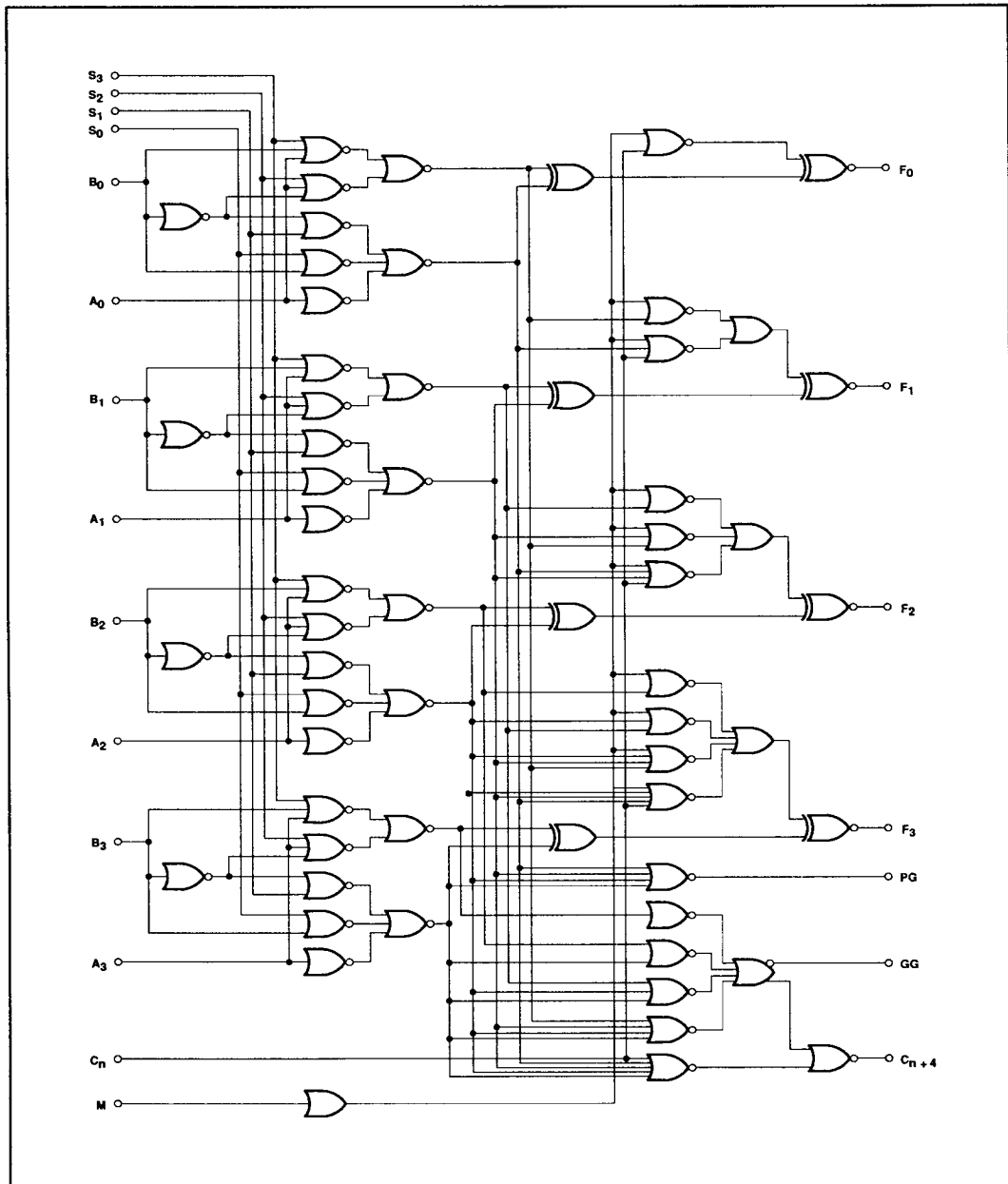
PIN CONFIGURATION



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LOGIC DIAGRAM



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FUNCTION TABLE

FUNCTION SELECT INPUTS				OUTPUT FUNCTION F		
				M = HIGH (Logic Mode)	M = LOW (Arithmetic Mode)	
S ₃	S ₂	S ₁	S ₀	C _n = H or L	C _n = LOW	C _n = HIGH
L	L	L	L	$\bar{A}$	A	A plus 1
L	L	L	H	$\bar{A} + \bar{B}$	A plus $A\bar{B}$	A plus $A\bar{B}$ plus 1
L	L	H	L	$\bar{A} + B$	A plus AB	A plus AB plus 1
L	L	H	H	HIGH	A plus A (2 times A)	A plus A plus 1
L	H	L	L	$\bar{A}B$	A + B	(A + B) plus 1
L	H	L	H	$\bar{B}$	(A + B) plus $A\bar{B}$	(A + B) plus $A\bar{B}$ plus 1
L	H	H	L	$\bar{A} \oplus \bar{B}$	A plus B	A plus B plus 1
L	H	H	H	A + $\bar{B}$	(A + B) plus A	(A + B) plus A plus 1
H	L	L	L	$\bar{A}B$	A + $\bar{B}$	(A + $\bar{B}$) plus 1
H	L	L	H	A $\oplus$ B	A minus B minus 1	A minus B
H	L	H	L	B	(A + $\bar{B}$) plus AB	(A + $\bar{B}$) plus AB plus 1
H	L	H	H	A + B	(A + $\bar{B}$) plus A	(A + $\bar{B}$) plus A plus 1
H	H	L	L	LOW	- 1 (2's complement)	Zero
H	H	L	H	$A\bar{B}$	$A\bar{B}$ minus 1	$A\bar{B}$
H	H	H	L	AB	AB minus 1	AB
H	H	H	H	A	A minus 1	A

H = High Voltage Level

L = Low Voltage Level

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ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER		LIMITS	UNIT
V_{EE}	Supply voltage		-8.0	V
V_{IN}	Input voltage (V_{IN} should never be more negative than V_{EE})		0 to V_{EE}	V
I_O	Output source current (continuous)		-50	mA
T_S	Storage temperature range		-55 to +150	°C
T_J	Maximum junction temperature	Ceramic Package	+165	°C
		Plastic Package	+150	°C

NOTE:

Operation beyond the limits set forth in this table may impair the useful life of the device. Unless otherwise noted, these limits are specified over the operating ambient temperature range.

DC OPERATING CONDITIONS

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT
			MIN.	NOM.	MAX.	
V_{CC1}, V_{CC2}	Circuit ground		0	0	0	V
V_{EE}	Supply voltage (negative)			-5.2		V
V_{IH}	High level input voltage	$T_A = -30^\circ\text{C}$			-890	mV
		$T_A = +25^\circ\text{C}$			-810	mV
		$T_A = +85^\circ\text{C}$			-700	mV
V_{IHT}	High level input threshold voltage	$T_A = -30^\circ\text{C}$	-1205			mV
		$T_A = +25^\circ\text{C}$	-1105			mV
		$T_A = +85^\circ\text{C}$	-1035			mV
V_{ILT}	Low level input threshold voltage	$T_A = -30^\circ\text{C}$			-1500	mV
		$T_A = +25^\circ\text{C}$			-1475	mV
		$T_A = +85^\circ\text{C}$			-1440	mV
V_{IL}	Low level input voltage	$T_A = -30^\circ\text{C}$	-1890			mV
		$T_A = +25^\circ\text{C}$	-1850			mV
		$T_A = +85^\circ\text{C}$	-1825			mV
T_A	Operating ambient temperature range		-30	+25	+85	°C

NOTE:

When operating at other than the specified V_{EE} voltage (-5.2V), the DC and AC Electrical Characteristics will vary slightly from specified values.

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DC ELECTRICAL CHARACTERISTICS $V_{CC1} = V_{CC2} = \text{ground}$, $V_{EE} = -5.2V \pm 0.010V$, $T_A = -30^\circ\text{C}$ to $+85^\circ\text{C}$ output loading 50Ω to $-2.0V \pm 0.010V$ unless otherwise specified^{1,3}

SYMBOL	PARAMETER		TEST CONDITIONS ²	LIMITS			UNIT
				MIN.	TYP.	MAX.	
V_{OH}	High level output voltage		$T_A = -30^\circ\text{C}$	-1060		-890	mV
			$T_A = +25^\circ\text{C}$	-960		-810	mV
			$T_A = +85^\circ\text{C}$	-890		-700	mV
V_{OHT}	High level output threshold voltage		$T_A = -30^\circ\text{C}$	-1080			mV
			$T_A = +25^\circ\text{C}$	-980			mV
			$T_A = +85^\circ\text{C}$	-910			mV
V_{OLT}	Low level output threshold voltage		$T_A = -30^\circ\text{C}$			-1655	mV
			$T_A = +25^\circ\text{C}$			-1630	mV
			$T_A = +85^\circ\text{C}$			-1595	mV
V_{OL}	Low level output voltage		$T_A = -30^\circ\text{C}$	-1890		-1675	mV
			$T_A = +25^\circ\text{C}$	-1850		-1650	mV
			$T_A = +85^\circ\text{C}$	-1825		-1615	mV
I_{IH}	High level input current	A_n inputs	$T_A = -30^\circ\text{C}$			350	μA
			$T_A = +25^\circ\text{C}$			220	μA
			$T_A = +85^\circ\text{C}$			220	μA
		B_n inputs	$T_A = -30^\circ\text{C}$			390	μA
			$T_A = +25^\circ\text{C}$			245	μA
			$T_A = +85^\circ\text{C}$			245	μA
		S_n inputs	$T_A = -30^\circ\text{C}$			425	μA
			$T_A = +25^\circ\text{C}$			265	μA
			$T_A = +85^\circ\text{C}$			265	μA
		C_n input	$T_A = -30^\circ\text{C}$			460	μA
			$T_A = +25^\circ\text{C}$			290	μA
			$T_A = +85^\circ\text{C}$			290	μA
		M input	$T_A = -30^\circ\text{C}$			320	μA
			$T_A = +25^\circ\text{C}$			200	μA
			$T_A = +85^\circ\text{C}$			200	μA
I_{IL}	Low level input current		$T_A = -30^\circ\text{C}$	0.5			μA
			$T_A = +25^\circ\text{C}$	0.5			μA
			$T_A = +85^\circ\text{C}$	0.3			μA
$-I_{EE}$	V_{EE} supply current		$T_A = -30^\circ\text{C}$			150	mA
			$T_A = +25^\circ\text{C}$		130	145	mA
			$T_A = +85^\circ\text{C}$			150	mA

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DC ELECTRICAL CHARACTERISTICS (Continued)

SYMBOL	PARAMETER	TEST CONDITIONS ²	LIMITS			UNIT
			MIN.	TYP.	MAX.	
$\frac{\Delta V_{OH}}{\Delta V_{EE}}$	High level output voltage compensation	$T_A = +25^\circ\text{C}$		0.016		V/V
$\frac{\Delta V_{OL}}{\Delta V_{EE}}$	Low level output voltage compensation			0.250		V/V
$\frac{\Delta V_{BB}}{\Delta V_{EE}}$	Reference bias voltage compensation			0.148		V/V

NOTES:

- The specified limits represent the worst case values for the parameter. Since these worst case values normally occur at the supply voltage and temperature extremes, additional noise immunity can be achieved by decreasing the allowable operating condition ranges.
- Conditions for testing shown in the tables are not necessarily worst case. For worst case testing guidelines, refer to DC Testing, Chapter 1, Section 3.
- The specified limits shown in the DC Electrical Characteristics table can be met only after thermal equilibrium has been established. Thermal equilibrium is established by applying power for at least 2 minutes, while maintaining transverse airflow of 2.5 meters/sec (500 linear feet/min) over the device, mounted either in a test socket or on a printed circuit board. Test voltage values are given in the DC Operating Conditions table.

AC ELECTRICAL CHARACTERISTICS $V_{CC1} = V_{CC2} = \text{ground}, V_{EE} = -5.2\text{V} \pm 0.010\text{V}$

SYMBOL	PARAMETER	TEST CONDITIONS ¹	LIMITS								UNIT
			T _A = -30°C		T _A = +25°C			T _A = +85°C			
			MIN.	MAX.	MIN.	TYP.	MAX.	MIN.	MAX.		
t _{PLH} t _{PHL}	Propagation delay C _n to C _{n+4}	Waveform 1 A ₀ , A ₁ , A ₂ , A ₃	1.00 1.00	5.10 5.10	1.10 1.10	3.10 3.10	5.00 5.00	1.10 1.10	5.40 5.40	ns ns	
t _{TLH} t _{THL}	Transition time ² C _n to C _{n+4}	Waveform 1 A ₀ , A ₁ , A ₂ , A ₃	1.00 1.00	3.20 3.20	1.00 1.00	2.00 2.00	3.00 3.00	1.00 1.00	3.20 3.20	ns ns	
t _{PLH} t _{PHL}	Propagation delay C _n to F ₁	Waveform 1 A ₀	1.70 1.70	7.20 7.20	2.00 2.00	4.50 4.50	7.00 7.00	2.00 2.00	7.50 7.50	ns ns	
t _{TLH} t _{THL}	Transition time ² C _n to F ₁	Waveform 1 A ₀	1.30 1.30	5.30 5.30	1.50 1.50	3.00 3.00	5.00 5.00	1.50 1.50	5.30 5.30	ns ns	
t _{PLH} t _{PHL}	Propagation delay A ₁ to F ₁	Waveform 1	2.60 2.60	10.40 10.40	3.00 3.00	6.50 6.50	10.00 10.00	3.00 3.00	10.80 10.80	ns ns	
t _{TLH} t _{THL}	Transition time ² A ₁ to F ₁	Waveform 1	1.30 1.30	5.40 5.40	1.50 1.50	3.00 3.00	5.00 5.00	1.50 1.50	5.30 5.30	ns ns	
t _{PLH} t _{PHL}	Propagation delay A ₁ to PG	Waveform 1 S ₀ , S ₃	1.60 1.60	7.00 7.00	2.00 2.00	5.00 5.00	6.50 6.50	2.00 2.00	7.00 7.00	ns ns	
t _{TLH} t _{THL}	Transition time ² A ₁ to PG	Waveform 1 S ₀ , S ₃	0.80 0.80	3.70 3.70	1.10 1.10	2.00 2.00	3.50 3.50	1.10 1.10	3.80 3.80	ns ns	
t _{PLH} t _{PHL}	Propagation delay A ₁ to GG	Waveform 1 A ₀ , A ₂ , A ₃ , C _n	1.10 1.10	7.40 7.40	2.00 2.00	4.50 4.50	7.00 7.00	1.30 1.30	7.70 7.70	ns ns	
t _{TLH} t _{THL}	Transition time ² A ₁ to GG	Waveform 1 A ₀ , A ₂ , A ₃ , C _n	1.20 1.20	5.10 5.10	1.50 1.50	4.00 4.00	5.00 5.00	1.20 1.20	5.30 5.30	ns ns	
t _{PLH} t _{PHL}	Propagation delay A ₁ to C _{n+4}	Waveform 1 A ₀ , A ₂ , A ₃ , C _n	1.70 1.70	7.30 7.30	2.00 2.00	5.00 5.00	7.00 7.00	2.00 2.00	7.80 7.80	ns ns	
t _{TLH} t _{THL}	Transition time ² A ₁ to C _{n+4}	Waveform 1 A ₀ , A ₂ , A ₃ , C _n	1.00 1.00	3.10 3.10	1.00 1.00	2.00 2.00	3.00 3.00	1.00 1.00	3.20 3.20	ns ns	
t _{PLH} t _{PHL}	Propagation delay B ₁ to F ₁	Waveform 1 S ₃ , C _n	2.70 2.70	11.30 11.30	3.00 3.00	8.00 8.00	11.00 11.00	3.00 3.00	11.90 11.90	ns ns	
t _{TLH} t _{THL}	Transition time ² B ₁ to F ₁	Waveform 1 S ₃ , C _n	1.20 1.20	5.30 5.30	1.50 1.50	3.50 3.50	5.00 5.00	1.50 1.50	5.30 5.30	ns ns	
t _{PLH} t _{PHL}	Propagation delay B ₁ to PG	Waveform 1 S ₀ , S ₃	1.60 1.60	7.70 7.70	2.00 2.00	6.00 6.00	7.50 7.50	2.00 2.00	8.00 8.00	ns ns	
t _{TLH} t _{THL}	Transition time ² B ₁ to PG	Waveform 1 S ₀ , S ₃	1.00 1.00	3.60 3.60	1.00 1.00	2.00 2.00	3.50 3.50	1.10 1.10	3.90 3.90	ns ns	

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AC ELECTRICAL CHARACTERISTICS (Continued)

SYMBOL	PARAMETER	TEST CONDITIONS ¹	LIMITS								UNIT
			T _A = -30°C		T _A = +25°C			T _A = +85°C			
			MIN.	MAX.	MIN.	TYP.	MAX.	MIN.	MAX.		
t _{PLH} t _{PHL}	Propagation delay B ₁ to GG	Waveform 1 S ₃ , C _n	1.70 1.70	8.20 8.20	2.00 2.00	6.00 6.00	8.00 8.00	2.00 2.00	8.60 8.60	ns ns	
t _{TLH} t _{THL}	Transition time ² B ₁ to GG	Waveform 1 S ₃ , C _n	1.40 1.40	5.20 5.20	1.50 1.50	3.00 3.00	5.00 5.00	1.20 1.20	5.40 5.40	ns ns	
t _{PLH} t _{PHL}	Propagation delay B ₁ to C _{n+4}	Waveform 1 S ₃ , C _n	1.80 1.80	8.20 8.20	2.00 2.00	6.00 6.00	8.00 8.00	2.00 2.00	8.70 8.70	ns ns	
t _{TLH} t _{THL}	Transition time ² B ₁ to C _{n+4}	Waveform 1 S ₃ , C _n	0.90 0.90	3.10 3.10	1.00 1.00	2.00 2.00	3.00 3.00	1.00 1.00	3.20 3.20	ns ns	
t _{PLH} t _{PHL}	Propagation delay M to F ₁	Waveform 1	2.40 2.40	10.30 10.30	3.00 3.00	6.50 6.50	10.00 10.00	3.00 3.00	10.80 10.80	ns ns	
t _{TLH} t _{THL}	Transition time ² M to F ₁	Waveform 1	1.10 1.10	5.10 5.10	1.50 1.50	4.00 4.00	5.00 5.00	1.50 1.50	5.30 5.30	ns ns	
t _{PLH} t _{PHL}	Propagation delay S ₁ to F ₁	Waveform 1 A ₁ , B ₁	2.50 2.50	10.70 10.70	3.00 3.00	6.50 6.50	10.00 10.00	3.00 3.00	10.80 10.80	ns ns	
t _{TLH} t _{THL}	Transition time ² S ₁ to F ₁	Waveform 1 A ₃ , B ₃	1.00 1.00	5.40 5.40	1.50 1.50	3.00 3.00	5.00 5.00	1.50 1.50	5.40 5.40	ns ns	
t _{PLH} t _{PHL}	Propagation delay S ₁ to PG	Waveform 1 A ₃ , B ₃	1.70 1.70	8.30 8.30	2.00 2.00	6.00 6.00	8.00 8.00	2.00 2.00	8.40 8.40	ns ns	
t _{TLH} t _{THL}	Transition time ² S ₁ to PG	Waveform 1 A ₃ , B ₃	0.80 0.80	5.10 5.10	1.10 1.10	3.00 3.00	5.00 5.00	1.10 1.10	5.20 5.20	ns ns	
t _{PLH} t _{PHL}	Propagation delay S ₁ to C _{n+4}	Waveform 1 A ₃ , B ₃	1.60 1.60	9.30 9.30	2.00 2.00	6.00 6.00	9.00 9.00	2.00 2.00	9.90 9.90	ns ns	
t _{TLH} t _{THL}	Transition time ² S ₁ to C _{n+4}	Waveform 1 A ₃ , B ₃	0.90 0.90	5.30 5.30	1.10 1.10	3.00 3.00	5.00 5.00	1.00 1.00	5.20 5.20	ns ns	
t _{PLH} t _{PHL}	Propagation delay S ₁ to GG	Waveform 1 A ₃ , B ₃	1.50 1.50	9.60 9.60	2.00 2.00	6.00 6.00	9.00 9.00	1.90 1.90	9.70 9.70	ns ns	
t _{TLH} t _{THL}	Transition time ² S ₁ to GG	Waveform 1 A ₃ , B ₃	0.80 0.80	6.20 6.20	0.80 0.80	3.00 3.00	6.00 6.00	0.80 0.80	6.50 6.50	ns ns	

NOTES:

1. Apply 1110mV to pins listed with 310mV applied to all other inputs.
2. All transition times are from 20% to 80% and 80% to 20% (refer to Waveform 1).
3. For AC test setup information, see AC Testing, Chapter 2, Section 3.

AC WAVEFORMS

